

Notice of References Cited			Application/Control No.	Applicant(s)/Patent Under Reexamination SUGAHARA ET AL.	
			Examiner Max Shikhman	Art Unit 2609	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2001/0033674 A1	10-2001	Chen et al.	382/100
*	B	US-2002/0009208 A1	01-2002	Alattar et al.	382/100
*	C	US-2002/0051560 A1	05-2002	Donescu et al.	382/100
*	D	US-2002/0083324 A1	06-2002	Hirai, Jun	713/176
*	E	US-6,449,380 B1	09-2002	Acharya et al.	382/100
*	F	US-2002/0157005 A1	10-2002	Brunk et al.	713/176
*	G	US-6,512,837 B1	01-2003	Ahmed, Farid	382/100
*	H	US-2003/0161496 A1	08-2003	HAYASHI et al.	382/100
*	I	US-6,971,010 B1	11-2005	Abdel-Mottaleb, Mohamed	713/176
*	J	US-6,990,213 B2	01-2006	Donescu, Ioana	382/100
K	US-				
L	US-				
M	US-				

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.